



## Advances in Perceptual Image Quality Metrics

Guest Editors:

**Prof. Dr. Marius Pedersen**

Norwegian University of Science  
and Technology, 7491  
Trondheim, Norway

**Prof. Dr. Aladine Chetouani**

Laboratory PRISME, University of  
Orleans, Château de la Source,  
45100 Orléans, France

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### Message from the Guest Editors

Dear Colleagues,

Advances are rapidly taking place in the imaging industry, with new products introduced to the market. To evaluate and benchmark image quality, objective image quality metrics have become very popular. This Special Issue aims to present new research on perceptual image quality metrics including but not limited to full-reference metrics, no-reference metrics, reduced-reference metrics, new databases for the evaluation of image quality metrics, pooling techniques, and perceptual models for use in image quality metrics.

### Keywords

- image quality metrics
- perception
- quality assessment
- quality databases





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**Prof. Dr. Giulio Nicola Cerullo**

Dipartimento di Fisica,  
Politecnico di Milano, Piazza L.  
da Vinci 32, 20133 Milano, Italy

## Message from the Editor-in-Chief

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Applied Sciences Editorial Office  
MDPI, St. Alban-Anlage 66  
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